

Tutorial: IR photodiodes and arrays: 2-6 and 3-5's material systems

O. Gravrand – LETI

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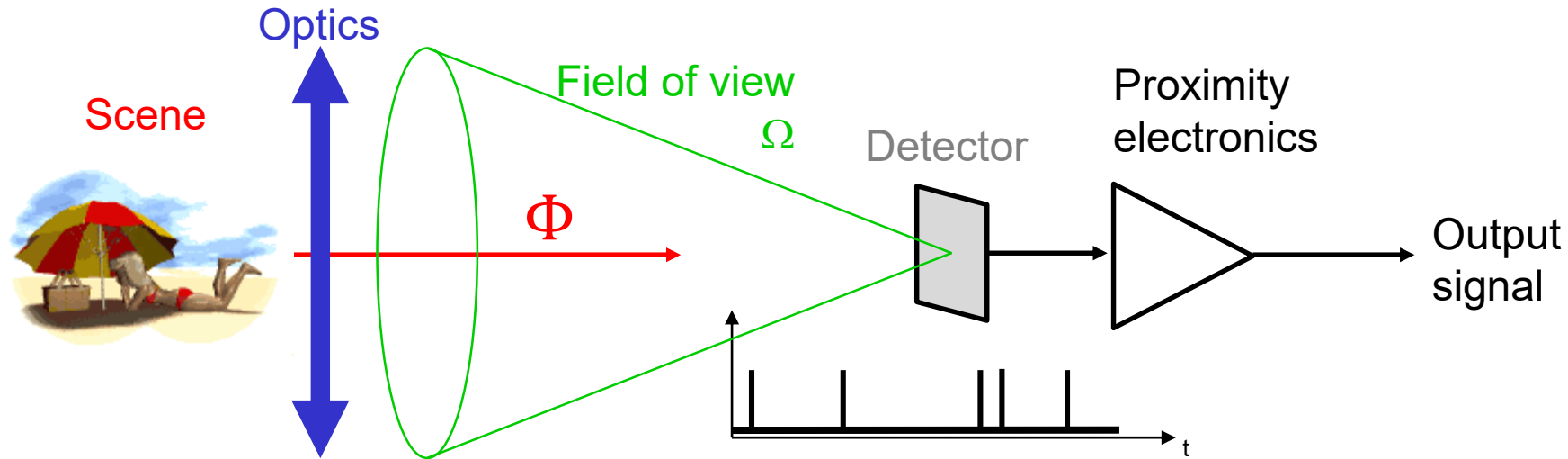
CNES Workshop 2023



Agenda

- 1. Introduction**
- 2. Material systems**
- 3. Focus on MCT as the big player**
- 4. Stability**
- 5. Radiation hardnes**
- 6. Focus on T2SL as the challenger**
- 7. Conclusion**

Detection by integration...



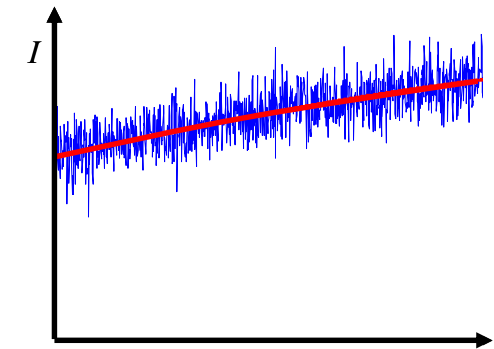
- Quantum detector = photon-electron conversion \rightarrow Quantum Efficiency QE

- Detected quantity = Photon flux $\Phi = N/T_{int}$

\rightarrow Poisson statistic $\sigma_N^2 = \langle N \rangle$ for a given integration time T_{int}

$$SNR = \frac{\langle N \rangle^2}{\sigma_N^2} = \langle N \rangle \quad \text{optimum}$$

- Proximity electronics \rightarrow Additional read out noise



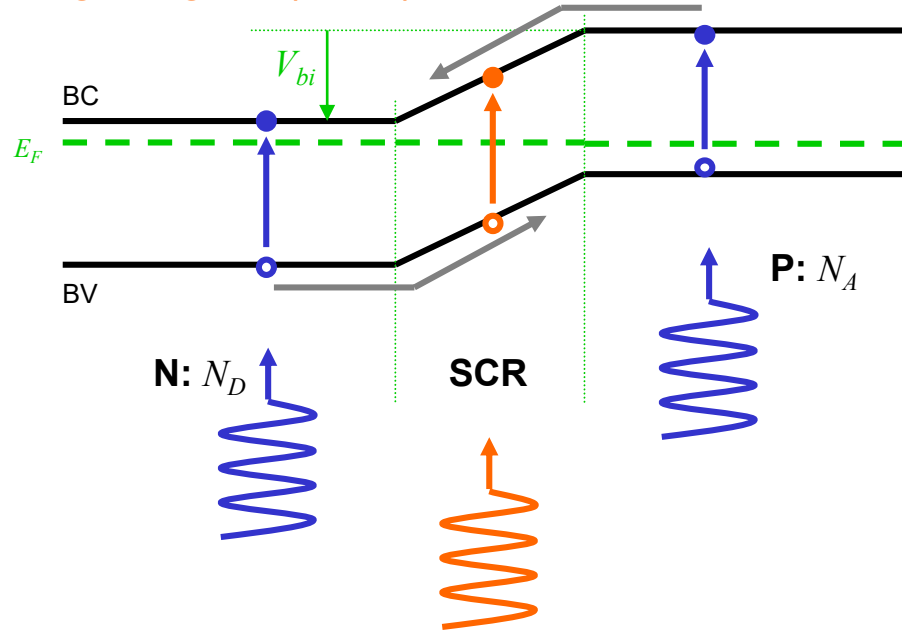
A good detector requires:

- High QE in order not to lose incoming information
- Low additional noise (dark current or RO noise) in order not to degrade this information

QE in PN junctions for IR

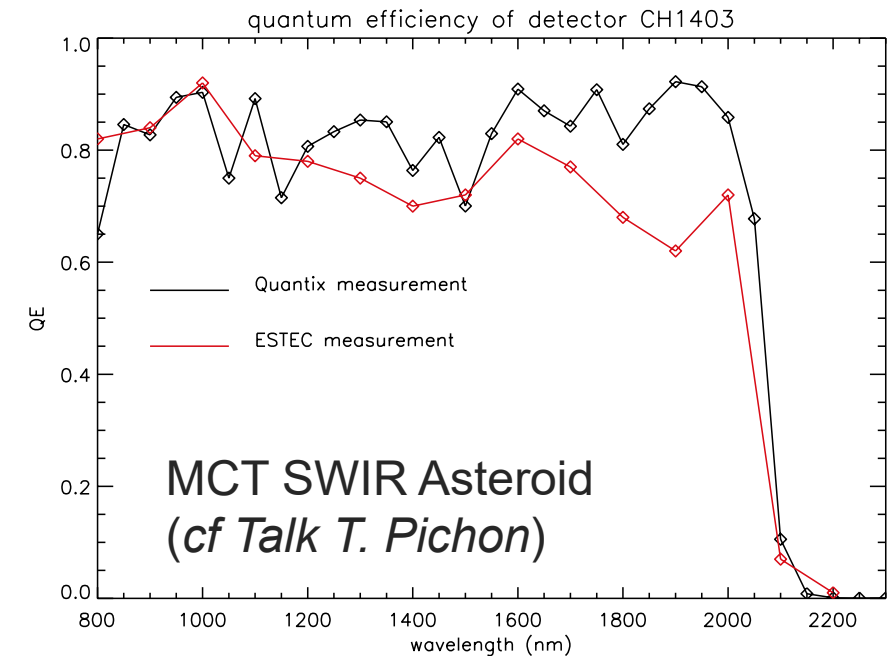
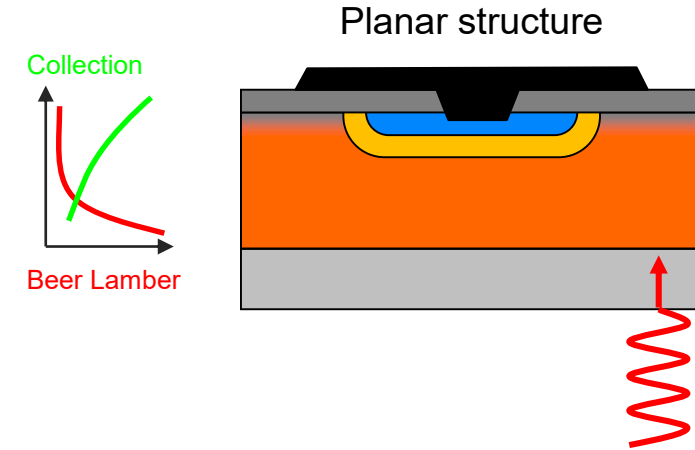
- Collected photocurrent limited by minority carriers

- N side: holes h^+
 - P side: electrons e^-
 - Space charge region (SCR) = depletion
- } Diffusion



- Usually the diode is asymmetric: dominated by one side
- QE is a tradeoff between:

- Absorption and thickness : $e^{-\alpha \times th}$
 - Collection efficiency
- } The thicker the better
(usually related to diffusion, ie mobility and carrier lifetime)



- Direct gap bulk \rightarrow high QE reachable
- QE measurement remains difficult....

Dark currents in PN junctions for IR

- N and P sides : **Auger** et **SRH** generation → diffusion limit

- SCR:

- No Auger in SCR
- SRH in SCR= GR

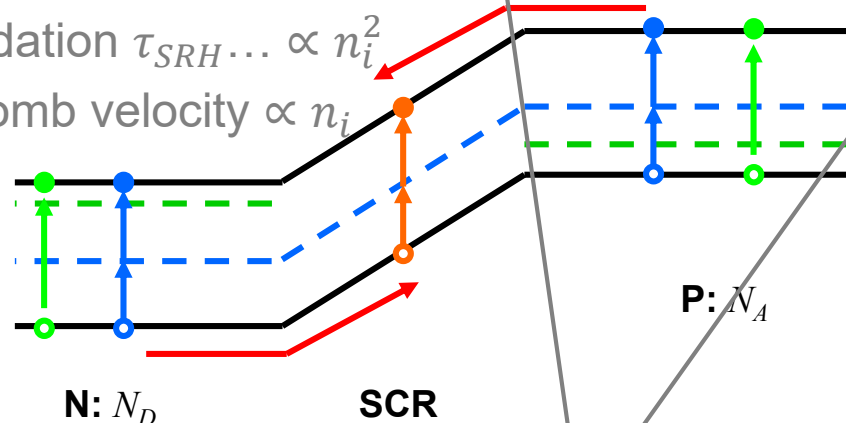
- Surface currents

- Local degradation $\tau_{SRH} \dots \propto n_i^2$
- Surface recomb velocity $\propto n_i$

$$I_{diff} = q \frac{n_i^2}{N_{dop}} \frac{V_{diff}}{\tau}$$

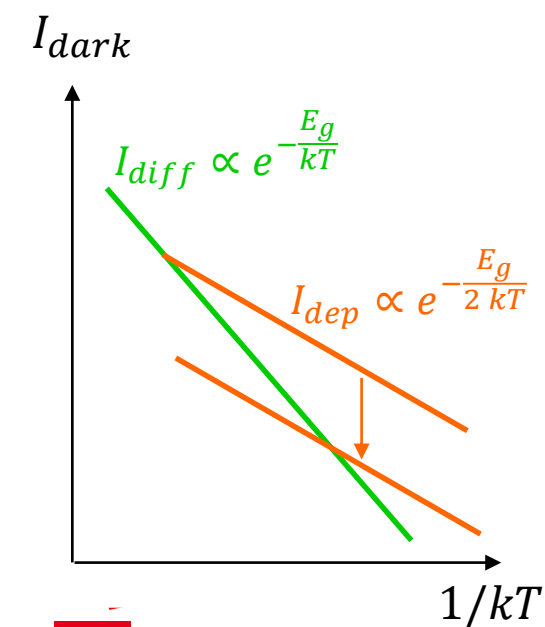
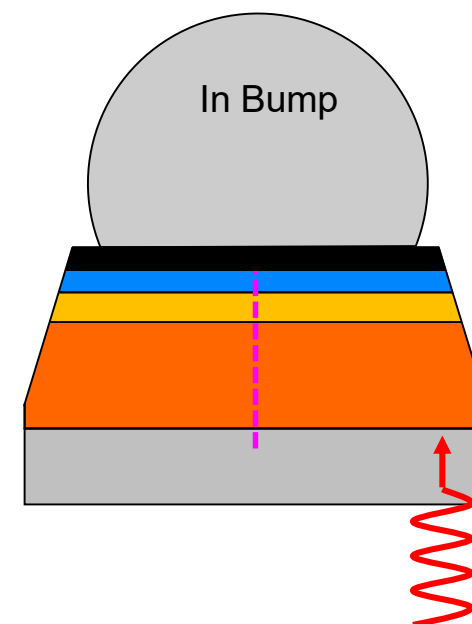
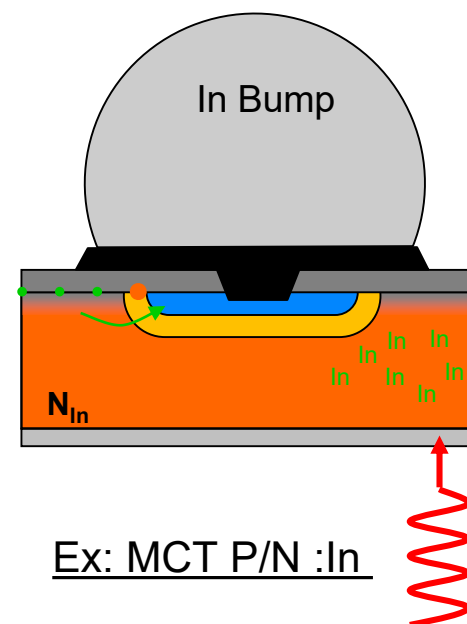
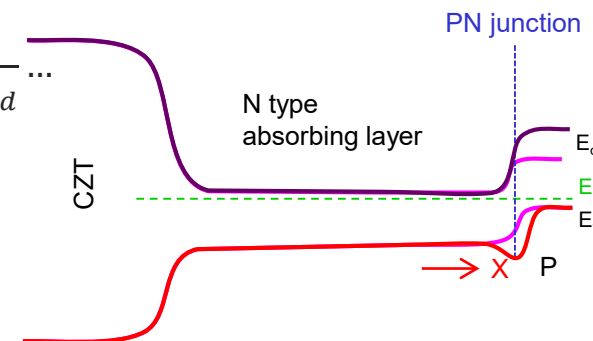
$$\frac{1}{\tau} = \frac{1}{\tau_{Auger}} + \frac{1}{\tau_{SRH}} + \frac{1}{\tau_{rad}} \dots$$

$$I_{SCR} = q \frac{n_i}{2 \tau_{SRH}} V_{SCR}$$

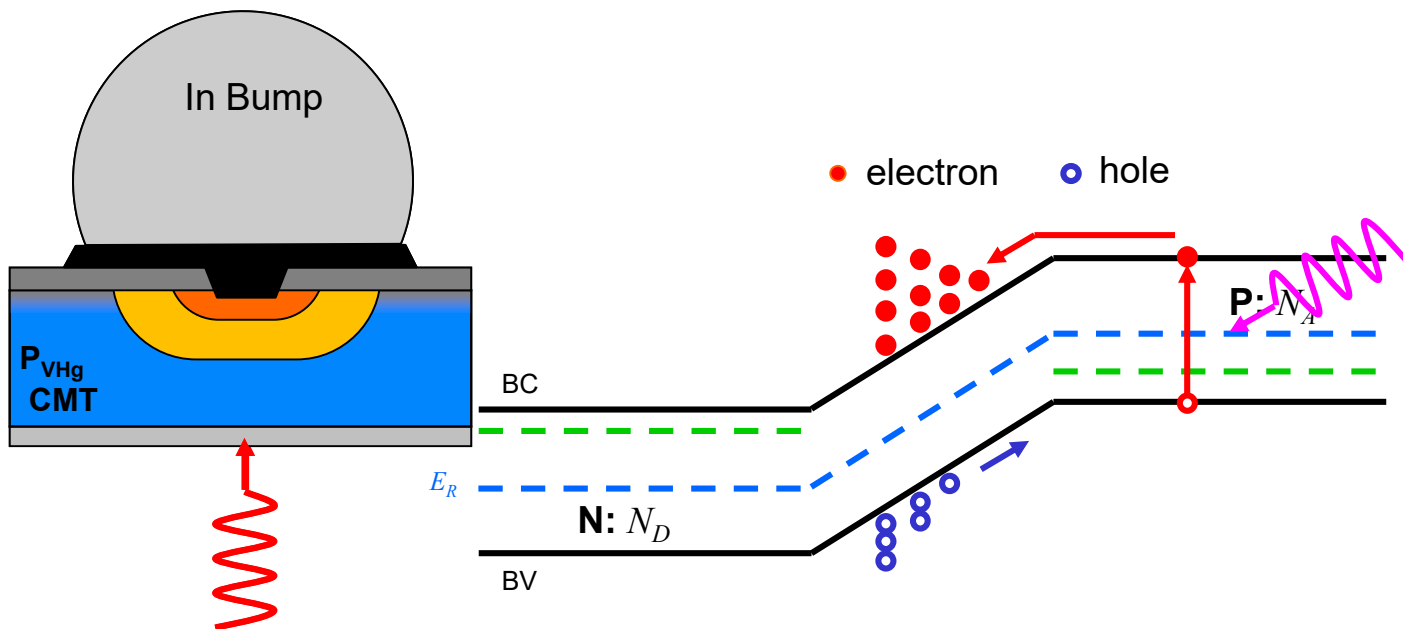


$$n_i \propto e^{-\frac{E_g}{2kT}}$$

Thermal behaviour is dominated by n_i



Impact ionization for Avalanche photodiodes



MCT shows :

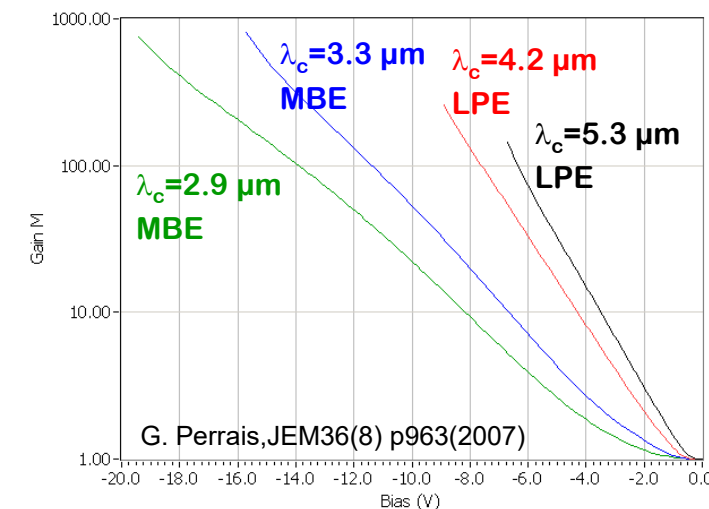
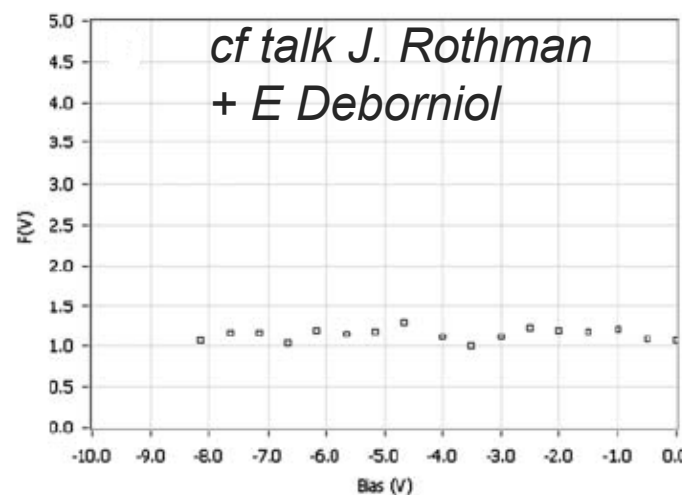
- Very high gain
- Close to unity XS noise
 - Single e- multiplication (no hole Xcation)
 - quasi deterministic P_{ionisation}
- !! tunnel current limitation

APD = Avalanche Photodiode
Photocurrent pre-amplification in the jonct
→ Overcome read out electronic noise

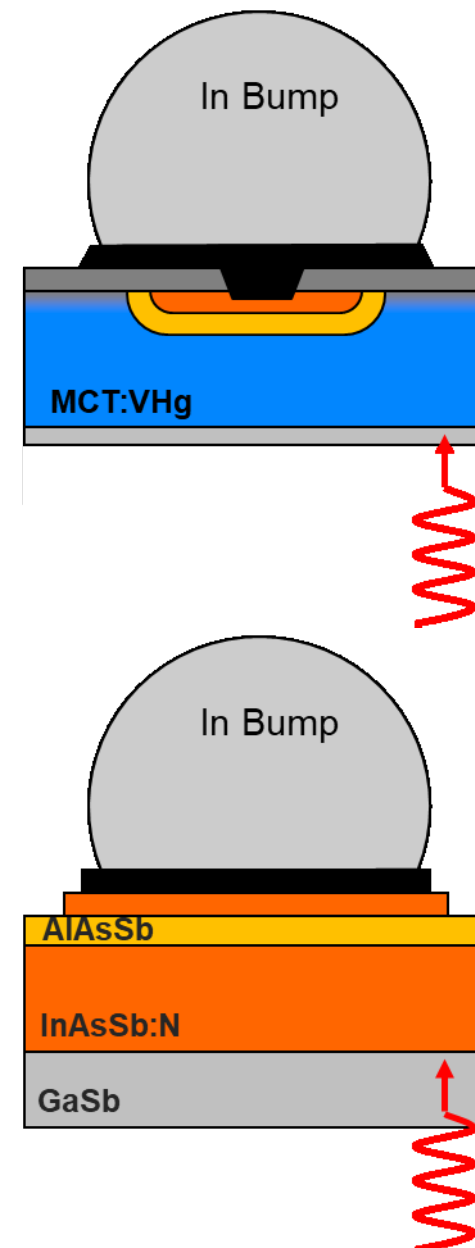
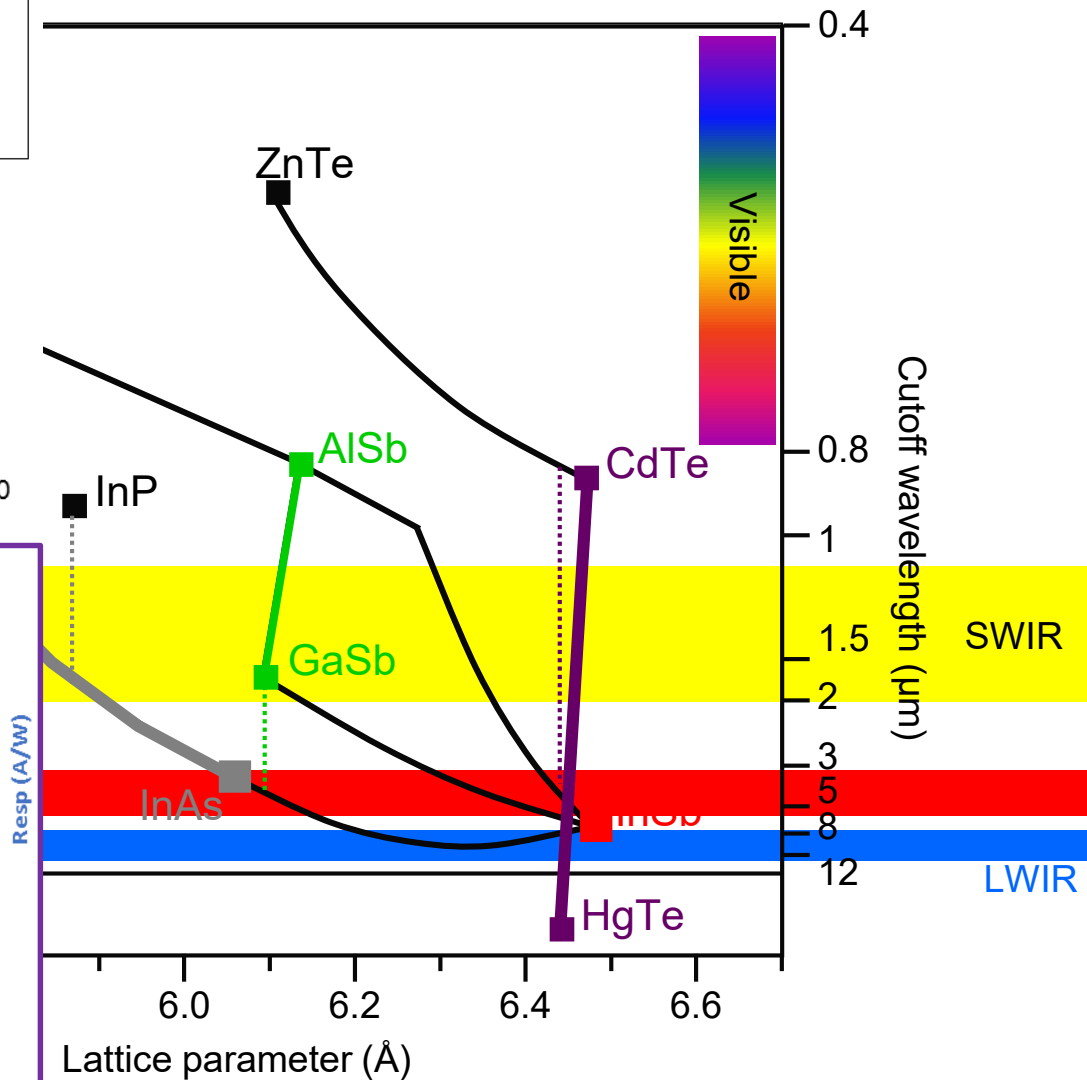
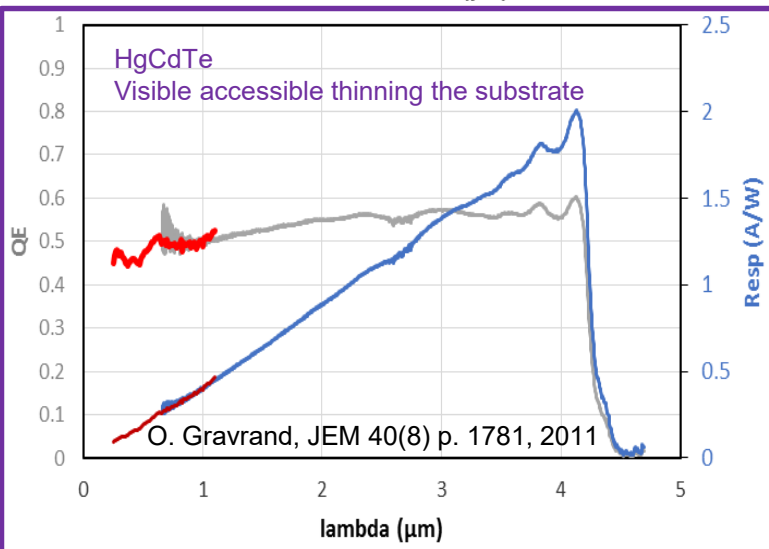
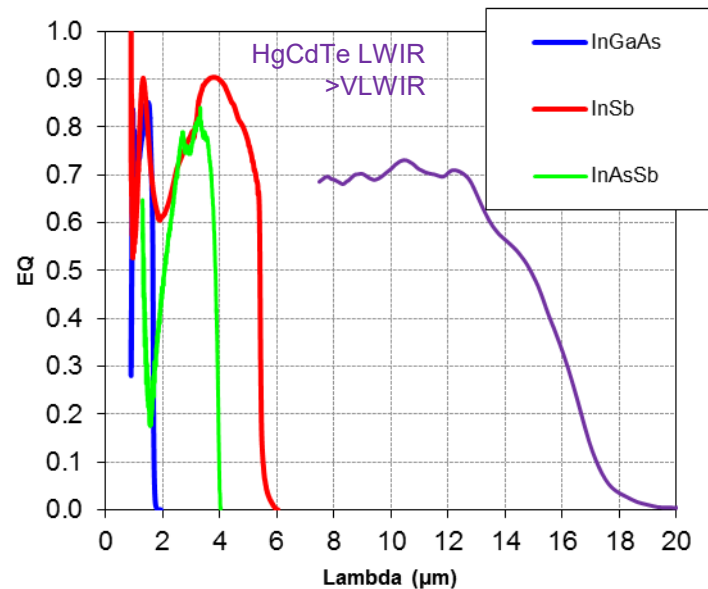
$$i_n = \sqrt{2qI} \text{ before amplification}$$

$$i_n = M \times \sqrt{2qI \times F} \text{ with gain } M$$

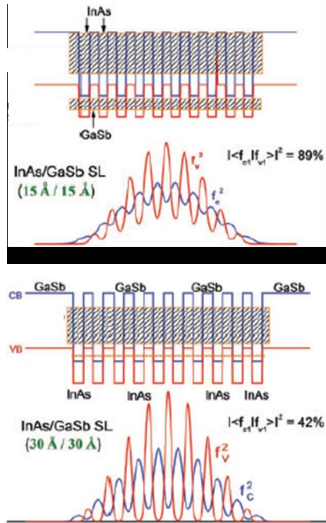
$$F = \frac{RSB_{in}}{RSB_{out}} \text{ XS noise}$$



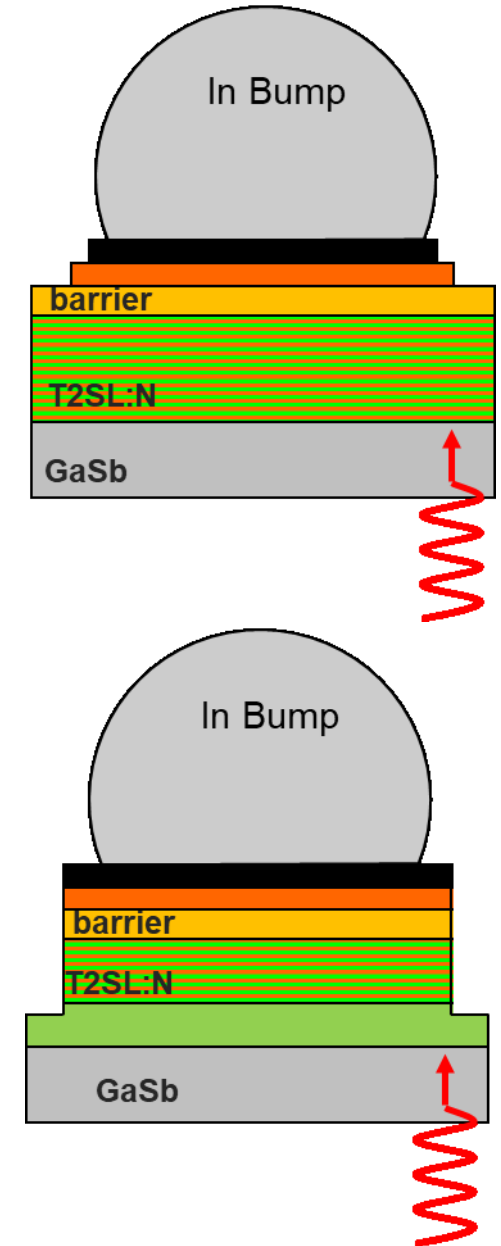
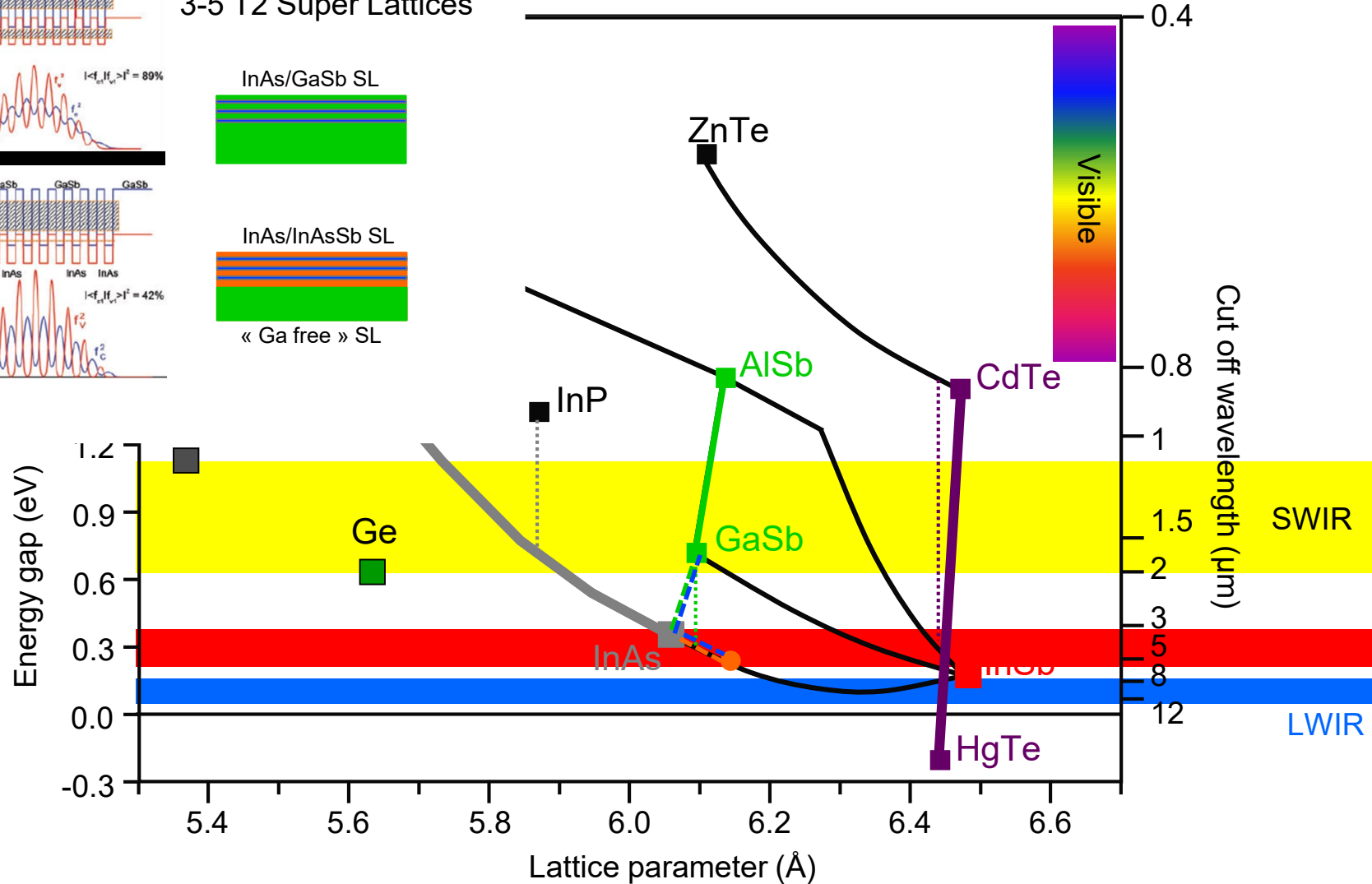
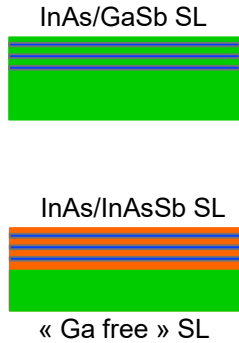
Spectral versatility is a material issue



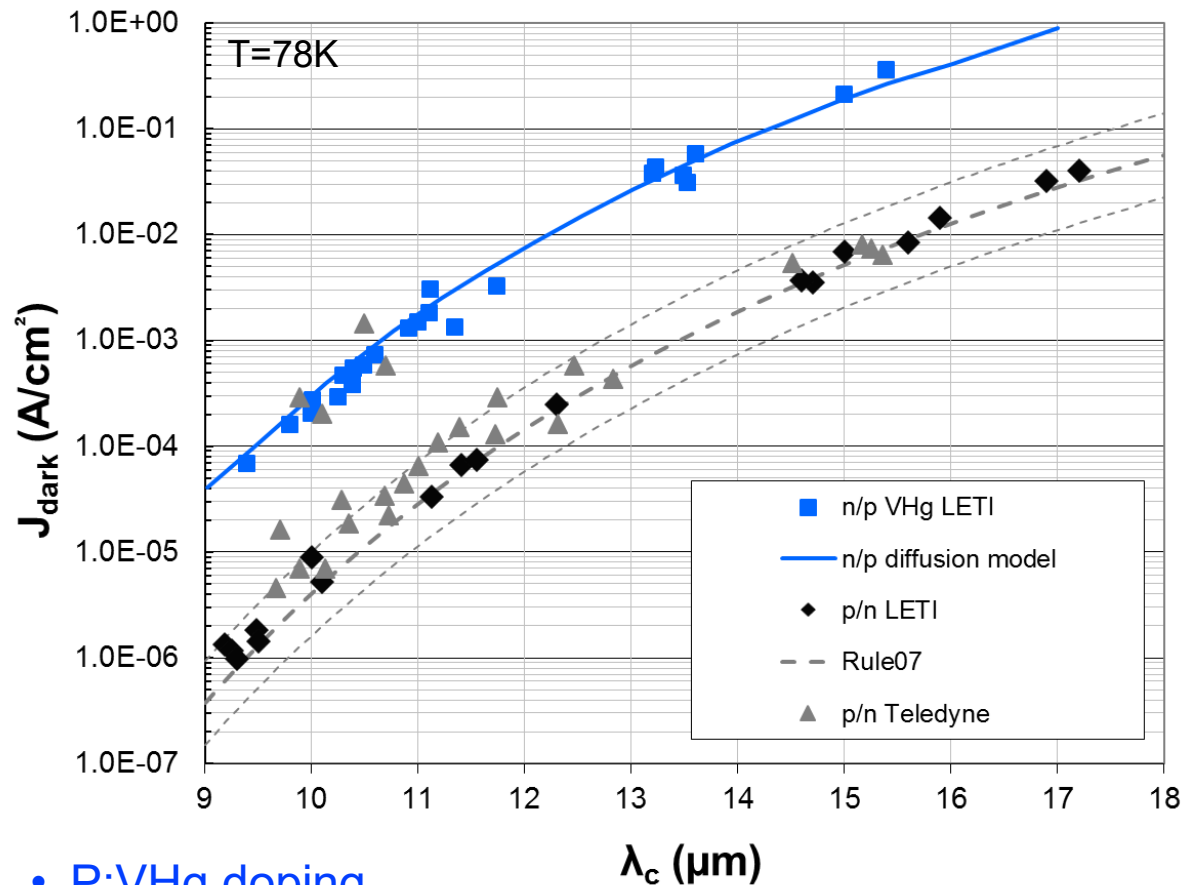
Spectral versatility is a material issue



3-5 T2 Super Lattices



MCT: Switch from VHg to extrinsic N:In doping



O. Gravrand, *SPIE* 636118–10 (2006)

O. Gravrand, *JEM* 38(8), (2009)

N. Baier, *SPIE*87042P (2013)

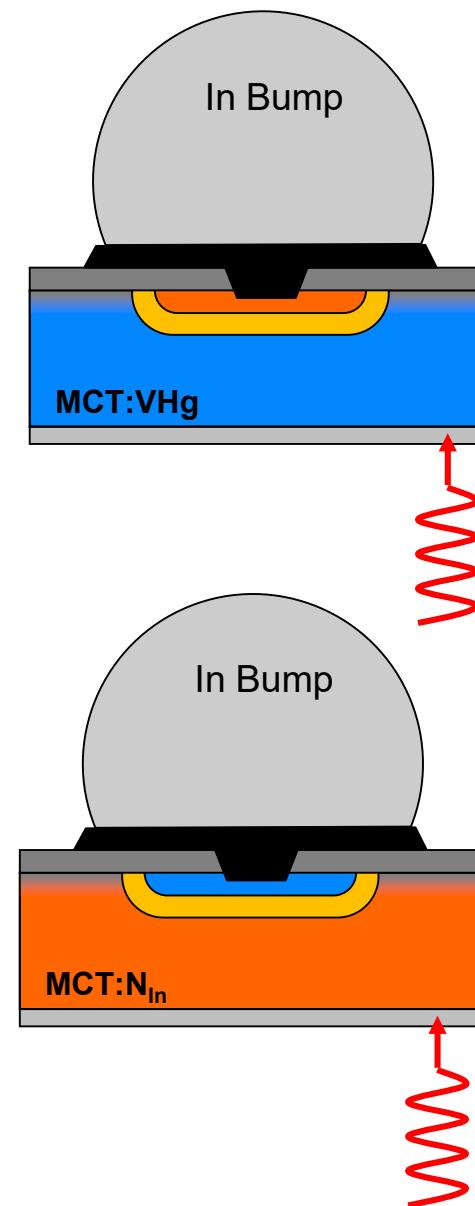
O. Gravrand, *JEM* 45(9) (2016)

W. Tennant, *JEM*, 37(9), p1406 (2008)

T. Chuh, *SPIE* 5563 p19 (2004).

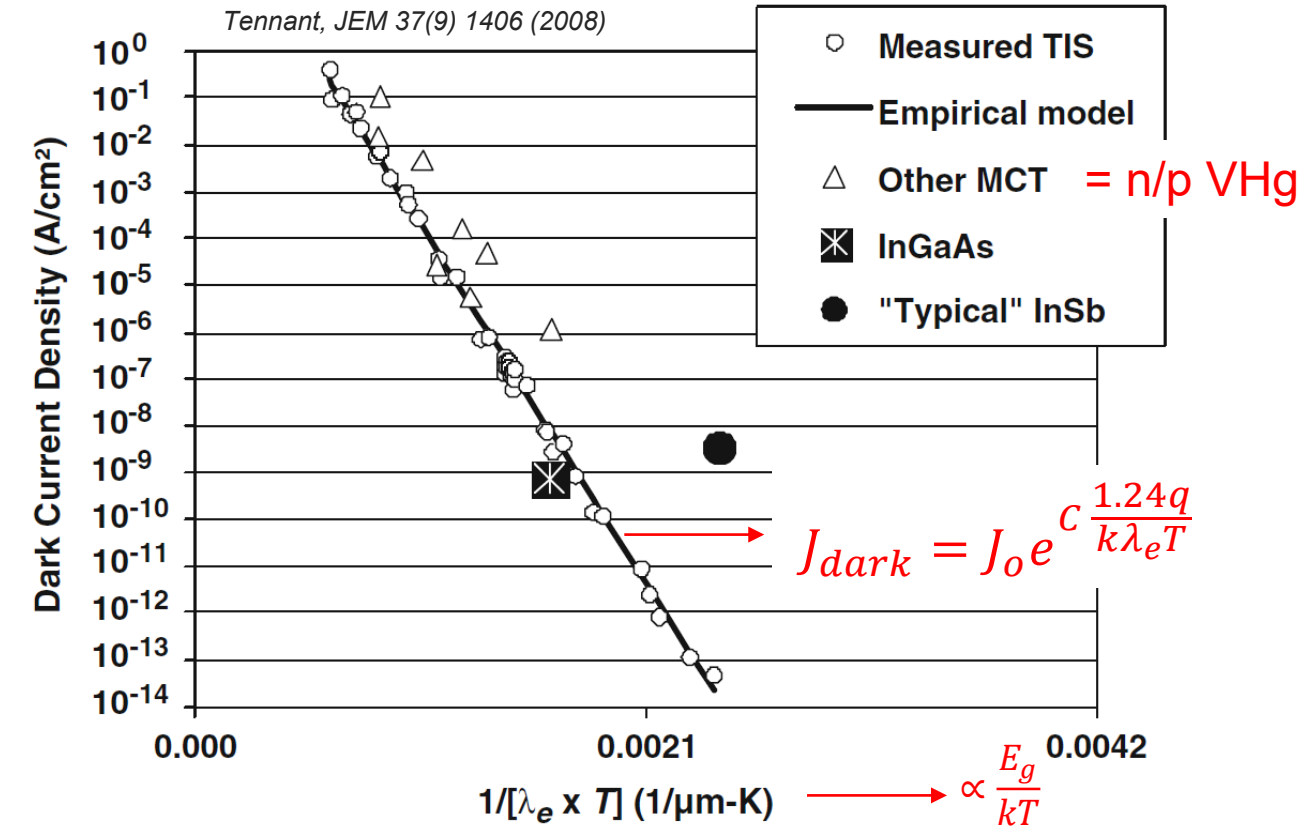
- P:VHg doping
 - Short lifetime ($\sim\text{ns}$), SRH VHg recombinaison
- Extrinsic N:In doping
 - Longer lifetime ($\sim\mu\text{s}$) Auger1
 - Larger $L_d = \sqrt{kT\mu\tau}$ → higher EQ

→ Gain close to x100 on I_{dark}

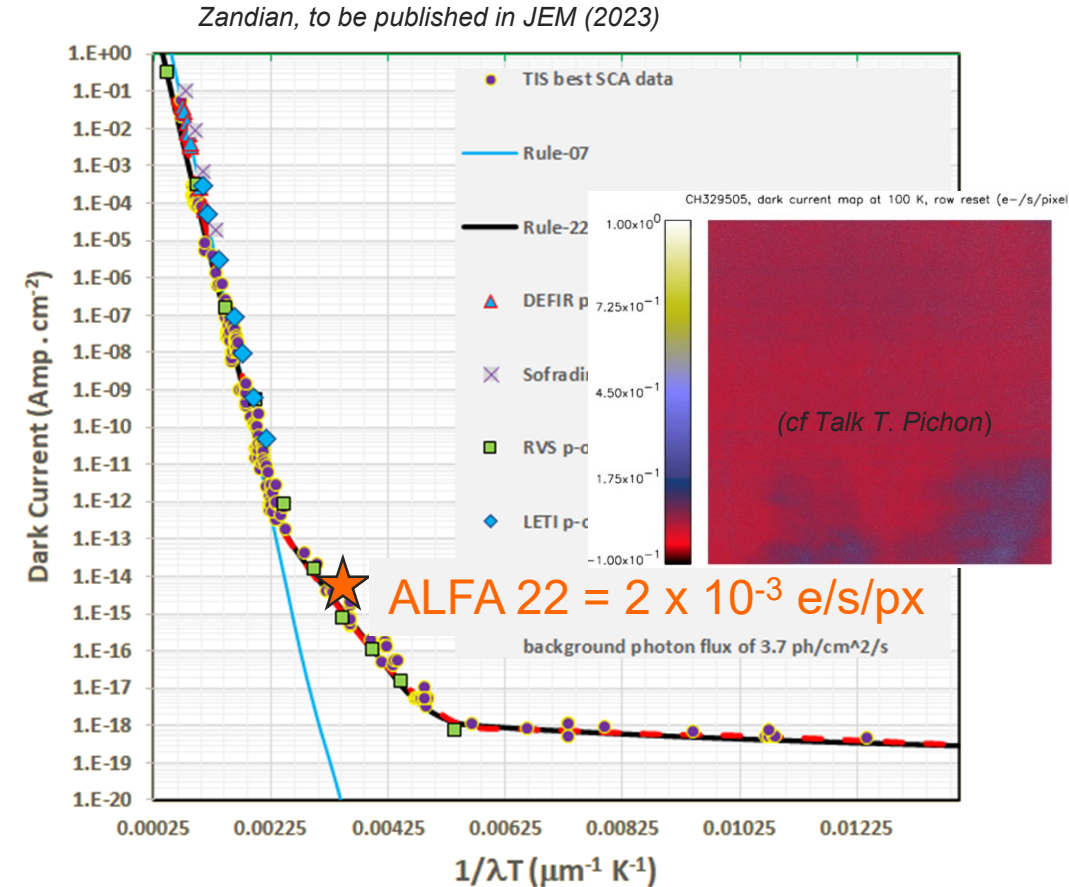


What is exactly this Rule 07? now Rule 22, when will it end?

$$J_{dark} = J_o(\lambda) \times \left[e^{-n_1 \frac{1.24q}{\lambda kT}} + C_2 e^{-n_2 \frac{1.24q}{\lambda kT}} \right] + \alpha \lambda^2 T$$

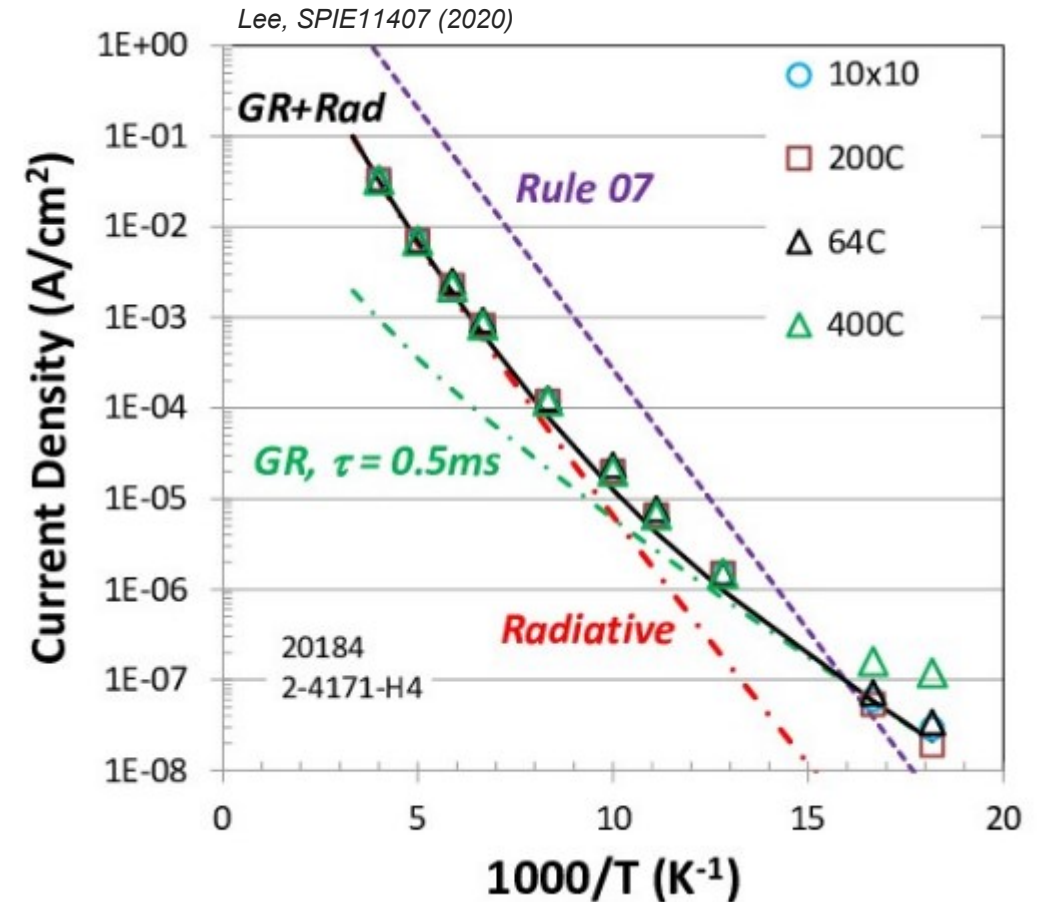
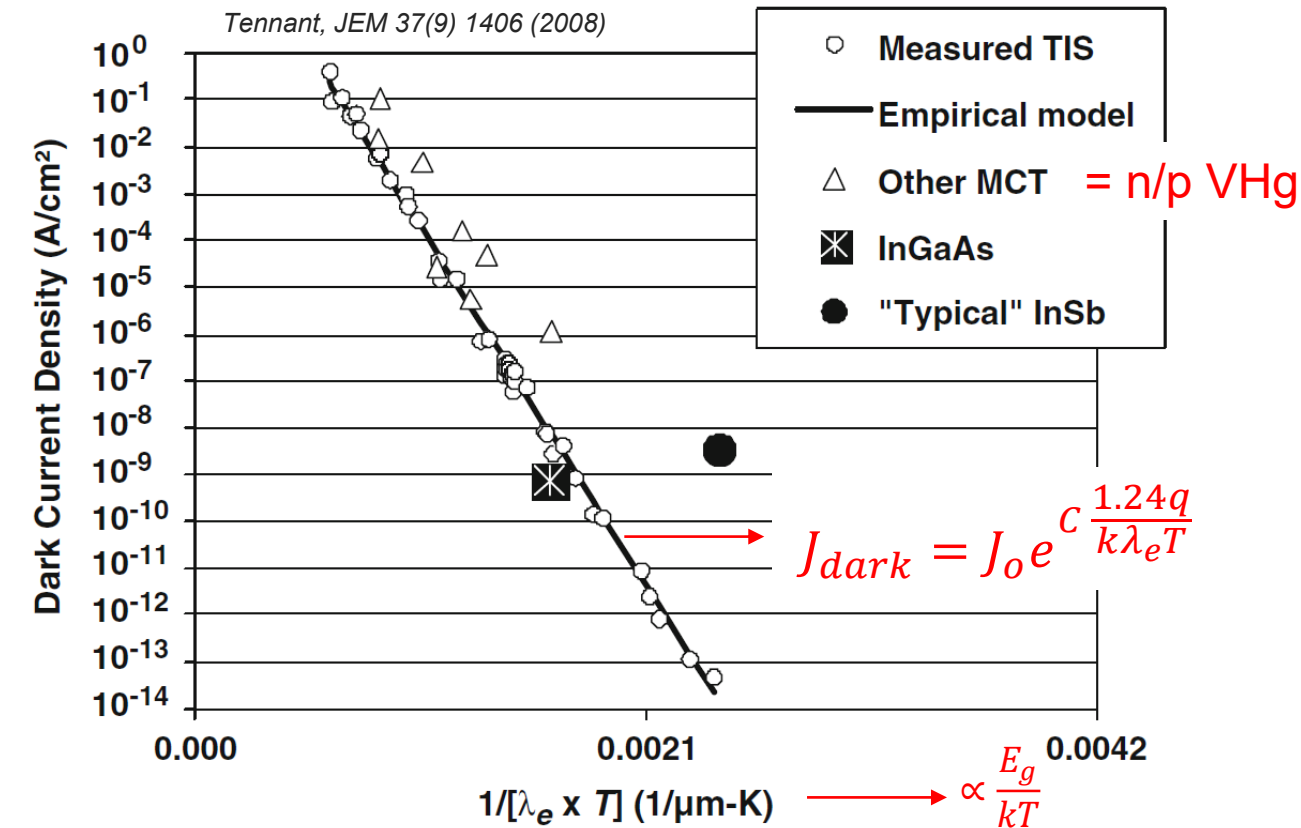


- **Rule07** is an easy to compute empirical law
- « good » p/n MCT diode diffusion dark current



- **Rule 22** to go down to very low currents
- Teledyne claims e-/month @ very low T°
- ALFA data in line with this description

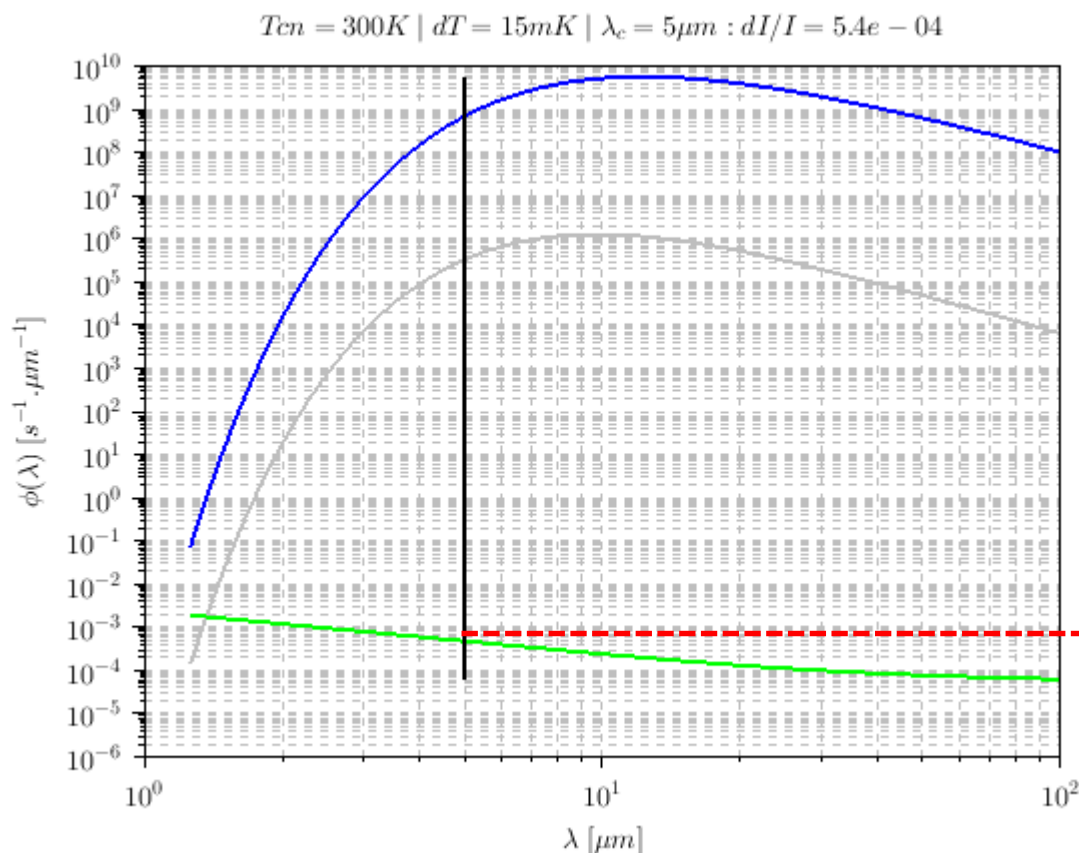
What is exactly this Rule 07? then law 19, now Rule 22, when will it end?



- Rule07 is an easy to compute empirical law
- « good » p/n MCT diode diffusion dark current

- Even lower current are demonstrated with a fully depleted structure = **law19**
- Seen at DEFIR and AIM

The need for very high stability in IR imaging...



$\phi(\lambda) = \text{Flux @ 300K BB}$

$d\phi(\lambda) = \text{delta Flux}$
300.015K - 300K

15mK NETD case

Ex :

$dT = 15mK, T_{cn} = 300K$ (pitch 15μm)

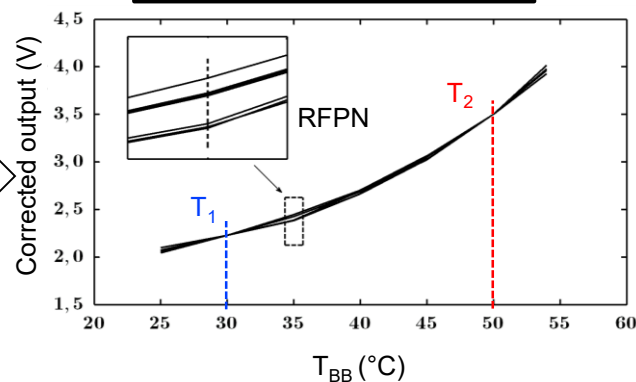
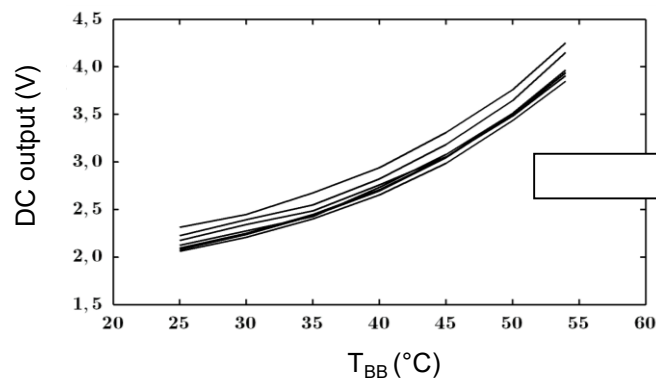
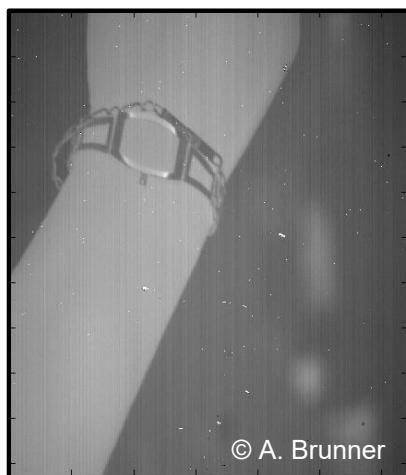
$$\rightarrow \frac{dI_{bb}}{I_{bb}} = 5 \cdot 10^{-4}$$

$$\frac{d\phi}{\phi}$$

- In an ambient IR image, all pixels are sensing very similar fluxes (high common BB background)
- IR imaging is a contrast imaging (\neq visible imaging)
- Need of a very high accurate/stable correction/calibration (10^{-4} typically)

Calibration = NUC stability

- Unfortunately, all pixels are not identical...
- 2 point correction usually used
 - Gain \Leftrightarrow Response x ROIC gain
 - Offset \Leftrightarrow Dark current + ROIC Offset



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- RFPN = spatial RMS noise after correction**

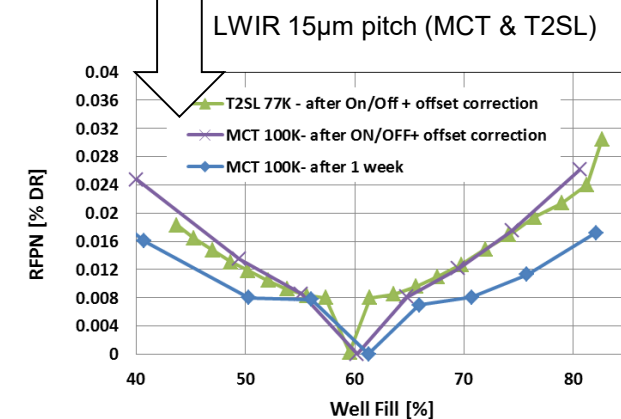
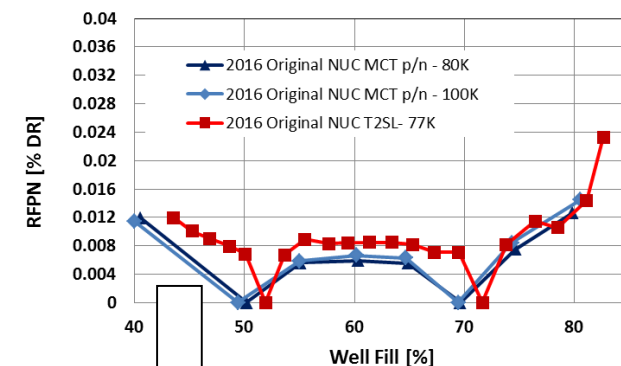
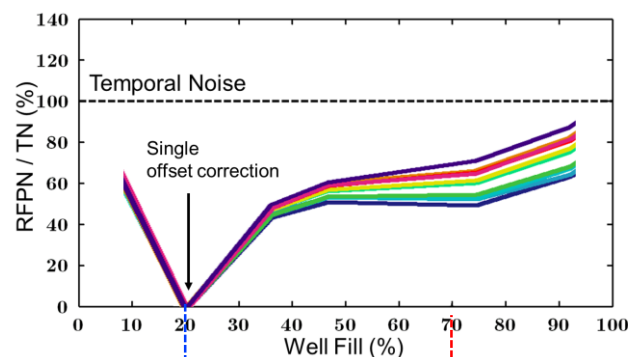
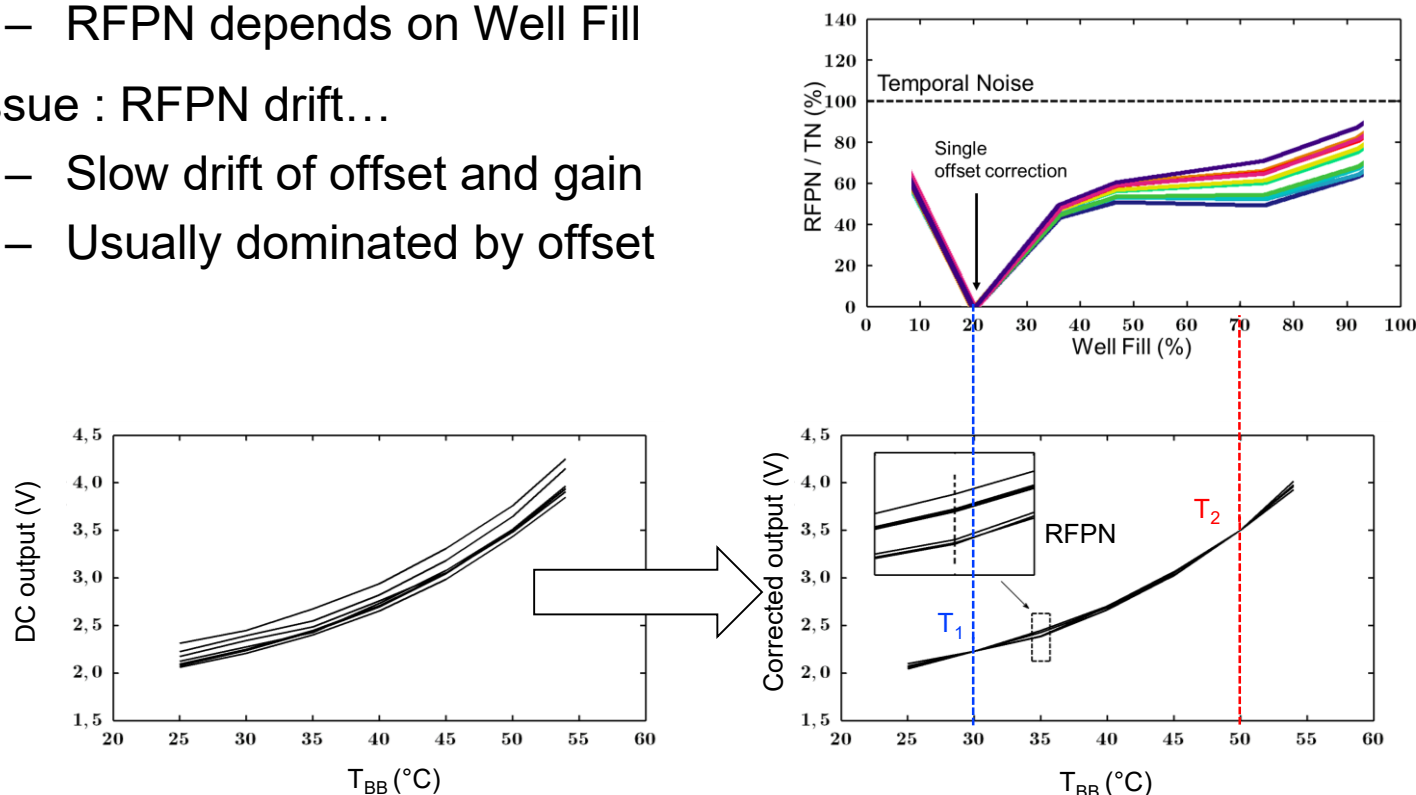
- RFPN depends on Well Fill

- Issue : RFPN drift...

- Slow drift of offset and gain

- Usually dominated by offset

- RFPN must remain low with a single offset correction

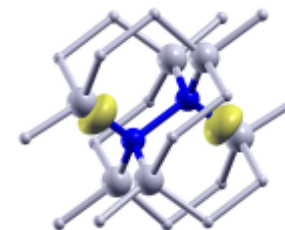


Rubaldo (2017), SPIE10177-49

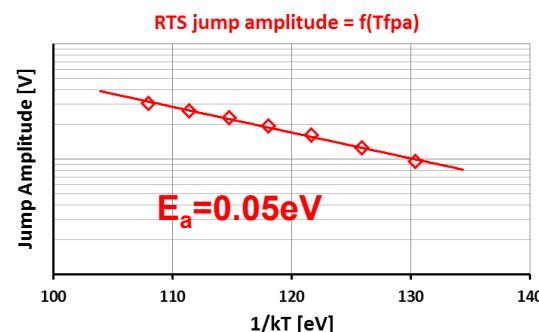
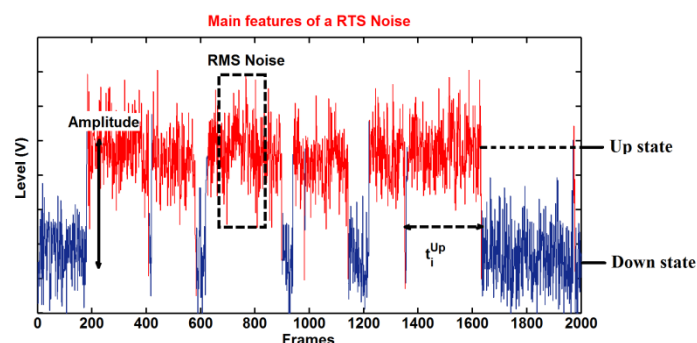
Klipstein (2016), SPIE 98190T-1

Dealing with LF noise, RTS is another issue

- RTS pixels
 - Dark current discrete fluctuations
 - Thermally activated : limiting the operating T° :
Higher and faster at higher temperature
 - $E_g/2$ activation energy : suggests depletion current

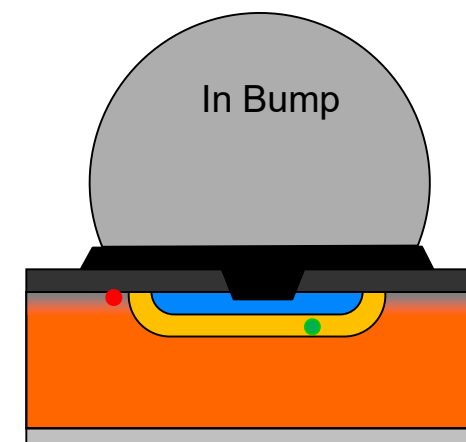


A Jay, IEEE Trans on Nuclear Science, 2018, 65 (2), pp.724-731.



MCT LW [Brunner et al, JEM, vol. 43, No. 8, 2014]

- Usually RTS density is correlated with noise distribution tails
- Metastable defects related to ...
 - the **SCR volume**
 - The **interfaces**



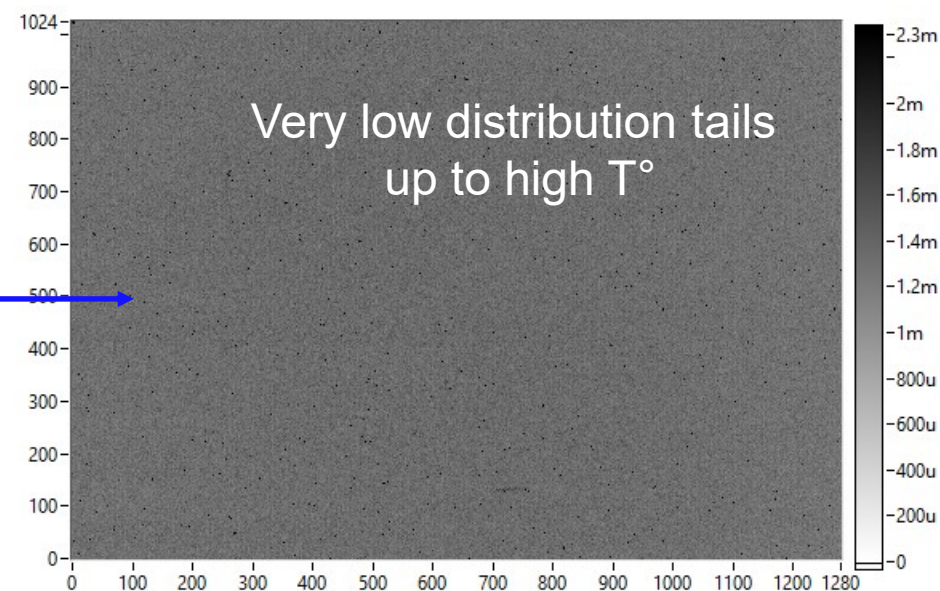
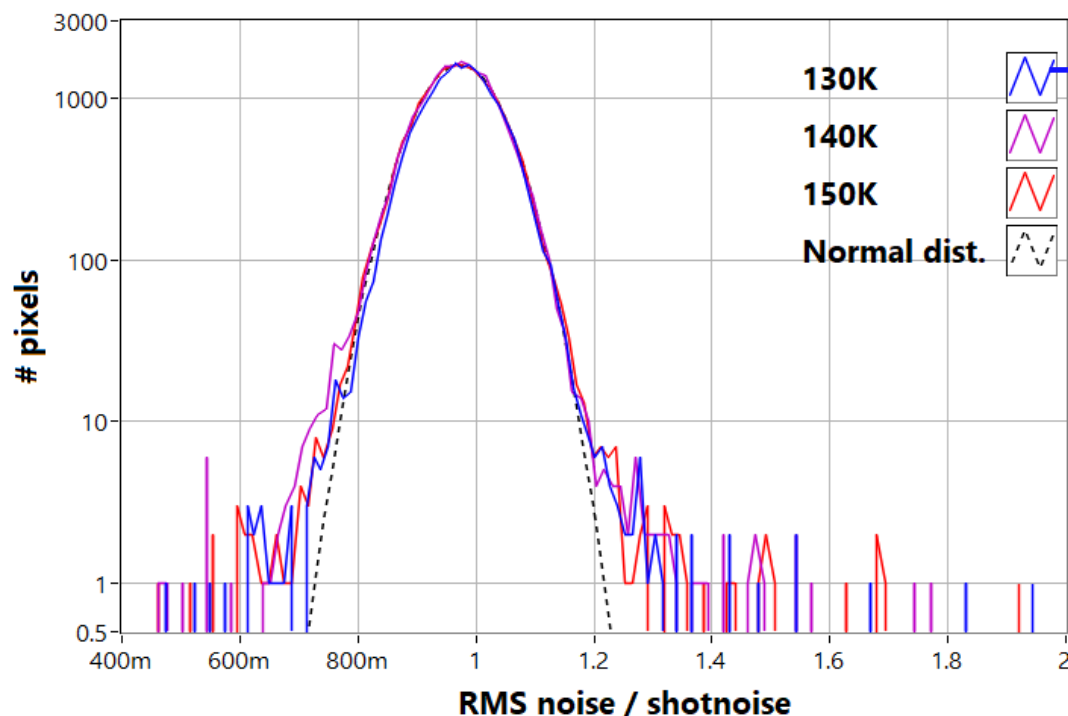
- Due to its weak Hg bounds and ionic nature, MCT is usually considered to be less stable than III-Vs...

Stability: Difference between II-VI and III-V?

- Strong efforts to mitigate those effects on both sides
- MCT = **New generation** p/n for encreased stability and small pitches @ DEFIR
 - pitch 7.5 μm
 - MW red
 - Target ope. T° 130K

+ ongoing dev^{nt} in LW band

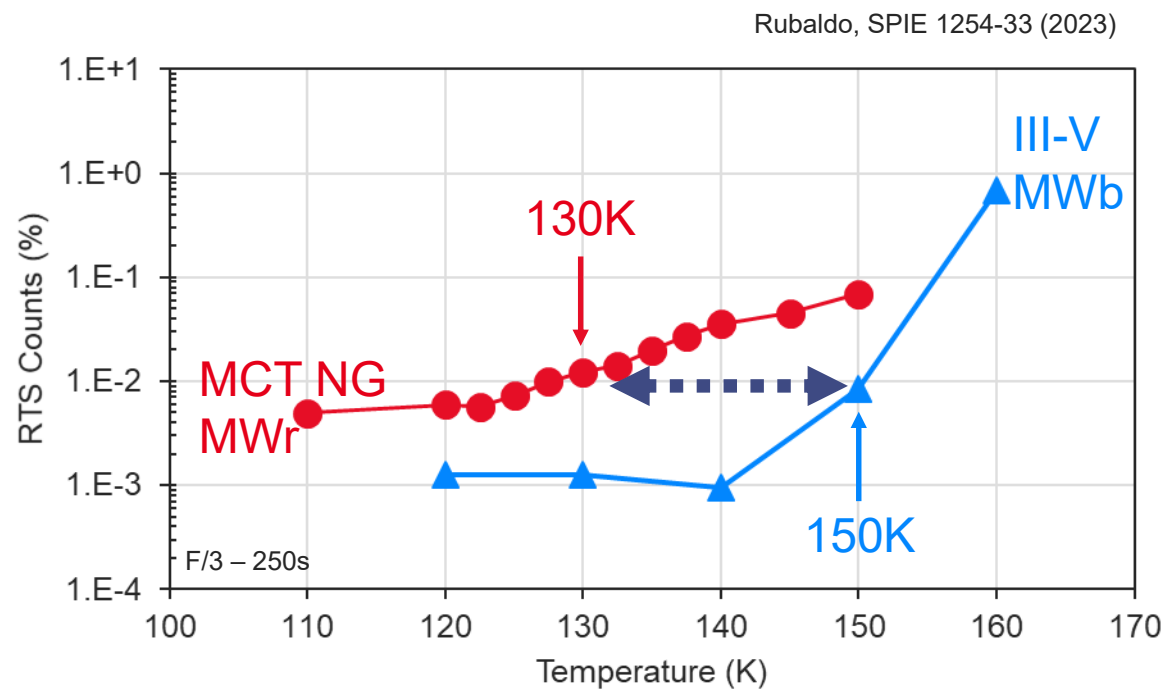
O. Gravrand, SPIE 12107 (2022)
N Baier, SPIE 13454 (2023)



T°	130K
λ_c	5.1 μm
QE	$\approx 85\%$
Op (I)	99.92%
Op (noise)	99.97%

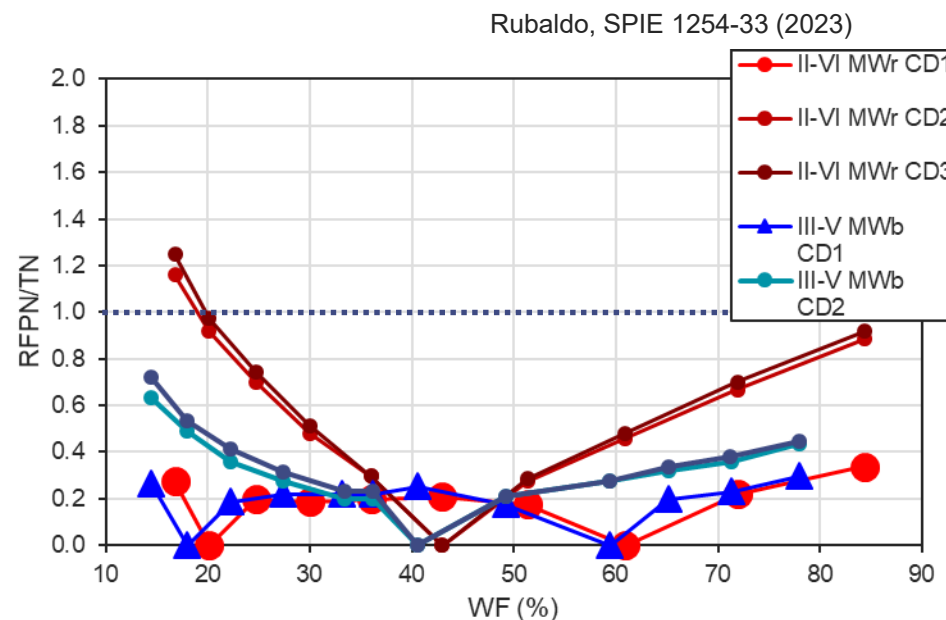
Stability: today's fight between II-VI and III-V?

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- Comparison with III-V by Lynred
 - Pitch 7.5 μm (same ROIC)
 - MW blue
 - Target ope. T° 150K
- RTS counts with T° : similar



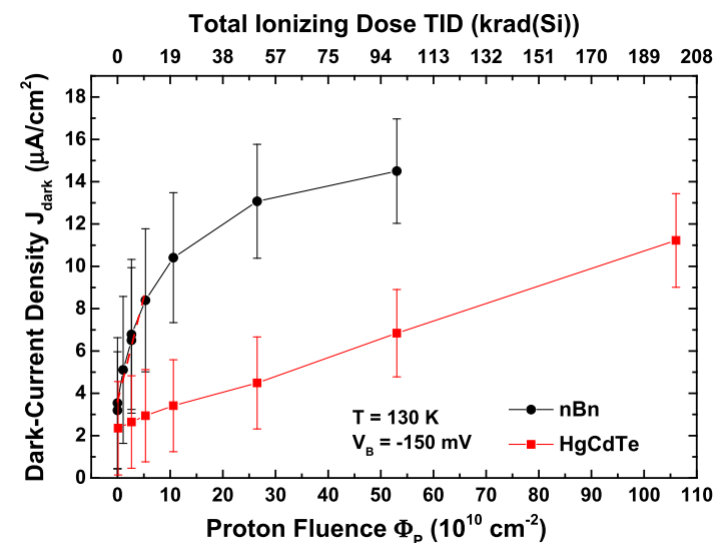
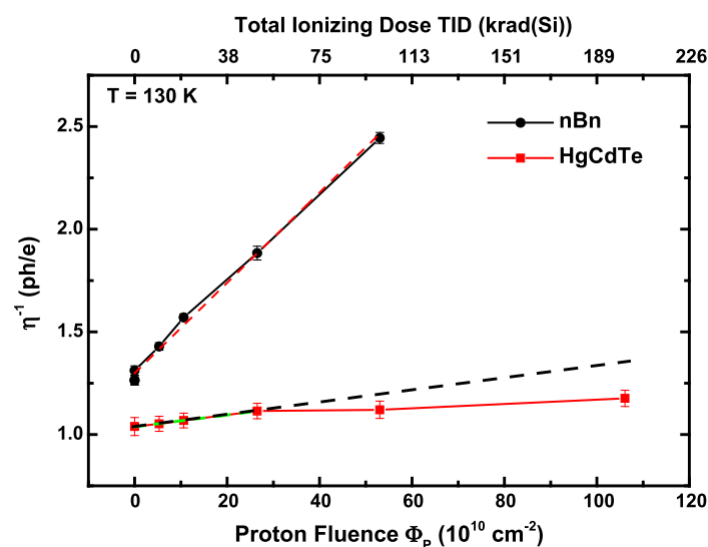
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- RTS counts with T° : similar
- RFPN evolution with cool down (CD)



Radiation hardness...

- InGaAs showed significant degradation on Spot 4 = Initial trauma? S. Barde, IEEE Trans Nuc Sci 47(6) (2000)
- MCT has the reputation of a rather radhard material system
- Previous work from AFRL suggest an advantage to MCT (ionic vs covalent crystal?) Jenkins 2017, JEM46(9) p5405



- On going work in the french community to build our own point of view
- See the « radiation effects » session with C. Bataillon, S. Dinand and M. Benfante PhD's

T2SL
Isabelle Ribet ONERA

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Conclusion

